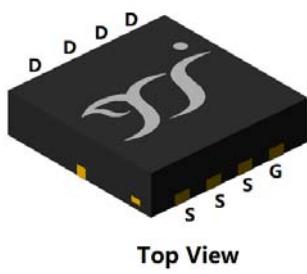
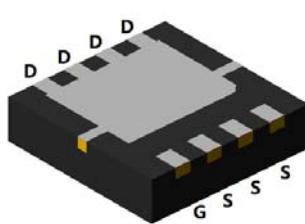
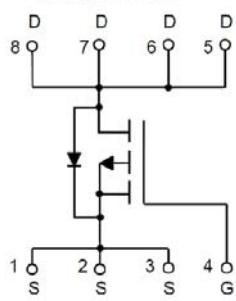


## P-Channel Enhancement Mode Field Effect Transistor


**Top View**

**Bottom View**
**DFN3333-8L**


### Product Summary

- $V_{DS}$  -100V
- $I_D$  -15A
- $R_{DS(ON)}$  (at  $V_{GS}=10V$ ) <110mΩ
- $R_{DS(ON)}$  (at  $V_{GS}=4.5V$ ) <120mΩ
- 100% EAS Tested

### General Description

- Split gate trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Part no. with suffix "Q" means AEC-Q101 qualified

### Applications

- Power switching application
- Uninterruptible power supply
- DC-DC converter
- 12V, 24V and 48V Automotive systems

### ■ Absolute Maximum Ratings ( $T_A=25^\circ C$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		$V_{DS}$	-100	V
Gate-source Voltage		$V_{GS}$	$\pm 20$	V
Drain Current	$T_A=25^\circ C$	$I_D$	-3.9	A
	$T_A=100^\circ C$		-2.5	
	$T_c=25^\circ C$		-15	
	$T_c=100^\circ C$		-9.5	
Pulsed Drain Current <sup>A</sup>		$I_{DM}$	-35	A
Avalanche energy <sup>B</sup>		EAS	64	mJ
Total Power Dissipation <sup>C</sup>	$T_A=25^\circ C$	$P_D$	2.5	W
	$T_A=100^\circ C$		1	
	$T_c=25^\circ C$		43	
	$T_c=100^\circ C$		17.2	
Junction and Storage Temperature Range		$T_J, T_{STG}$	-55~+150	°C

### ■ Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient <sup>D</sup>	Steady-State	$R_{\theta JA}$	40	50	°C/W
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	2.4	2.9	

### ■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJQ15GP10AQ	F1	Q15GP10A	5000	10000	100000	13" reel



# YJQ15GP10AQ

## ■ Electrical Characteristics ( $T_J=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-100			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-100V, V_{GS}=0V$			-1	$\mu A$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	-1.0	-1.8	-2.5	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-10A$		83	110	$m\Omega$
		$V_{GS}=-4.5V, I_D=-5A$		95	120	
Diode Forward Voltage	$V_{SD}$	$I_S=-15A, V_{GS}=0V$	-		-1.3	V
Maximum Body-Diode Continuous Current	$I_S$		-	-	-15	A
<b>Dynamic Parameters</b>						
Gate resistance	$R_G$	$f=1MHz, \text{Open drain}$ $V_{DS}=-25V, V_{GS}=0V, f=1MHz$	-	10	-	$\Omega$
Input Capacitance	$C_{iss}$		-	1200	-	$pF$
Output Capacitance	$C_{oss}$		-	200	-	
Reverse Transfer Capacitance	$C_{rss}$		-	25	-	
<b>Switching Parameters</b>						
Total Gate Charge	$Q_g$	$V_{GS}=-10V, V_{DS}=-50V, I_D=-5A$		20.1	-	$nC$
Gate-Source Charge	$Q_{gs}$		-	3.98	-	
Gate-Drain Charge	$Q_{gd}$		-	4.38	-	
Reverse Recovery Charge	$Q_{rr}$	$I_F=-5A, di/dt=100A/us$	-	140	-	$nC$
Reverse Recovery Time	$t_{rr}$		-	80	-	$ns$
Turn-on Delay Time	$t_{D(on)}$		-	10	-	$ns$
Turn-on Rise Time	$t_r$	$V_{GS}=-10V, V_{DD}=-50V, I_{DS}=-5A$ $R_{GEN}=6\Omega$	-	30	-	
Turn-off Delay Time	$t_{D(off)}$		-	77	-	
Turn-off fall Time	$t_f$		-	81	-	

A. Repetitive rating; pulse width limited by max. junction temperature.

B.  $T_J=25^\circ C$ ,  $V_{DD}=-50V$ ,  $V_G=-10V$ ,  $R_G=25\Omega$ ,  $L=0.5mH$ ,  $I_{AS}=-16A$ .

C.  $P_d$  is based on max. junction temperature, using junction-case thermal resistance.

D. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with  $TA = 25^\circ C$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10s$  and the maximum allowed junction temperature of  $150^\circ C$ . The value in any given application depends on the user's specific board design.

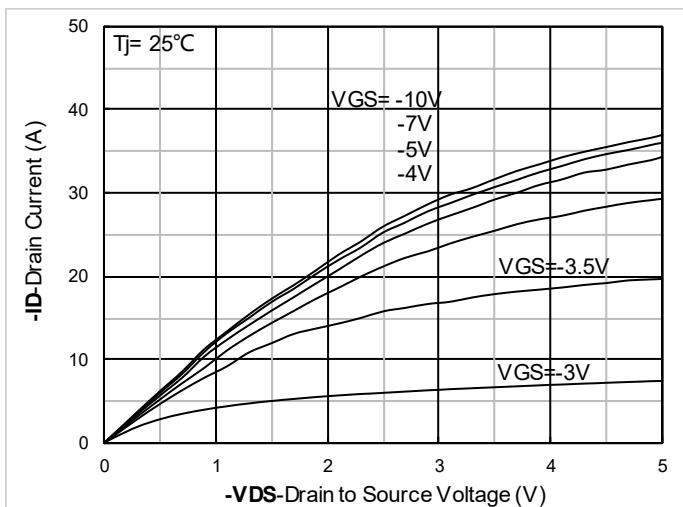
**■Typical Electrical and Thermal Characteristics Diagrams**

Figure 1. Output Characteristics

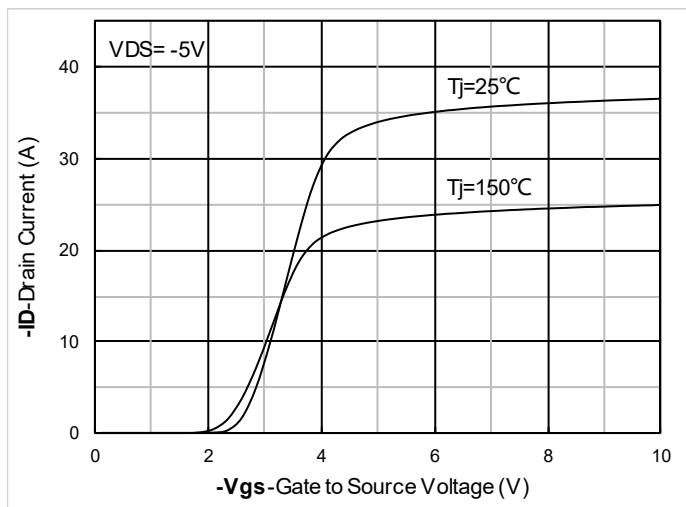


Figure 2. Transfer Characteristics

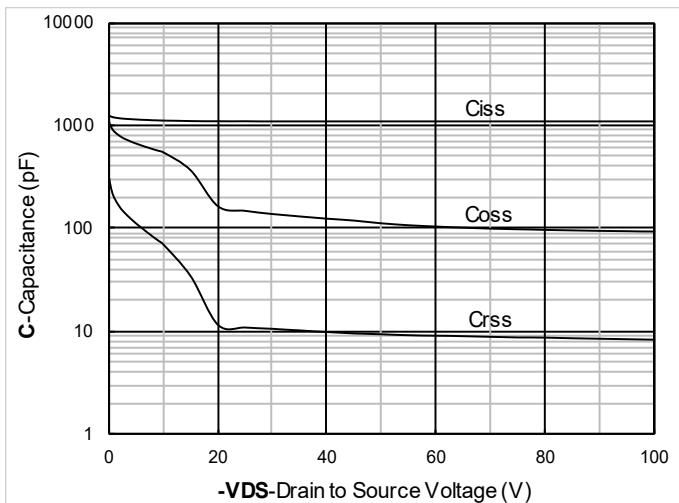


Figure 3. Capacitance Characteristics

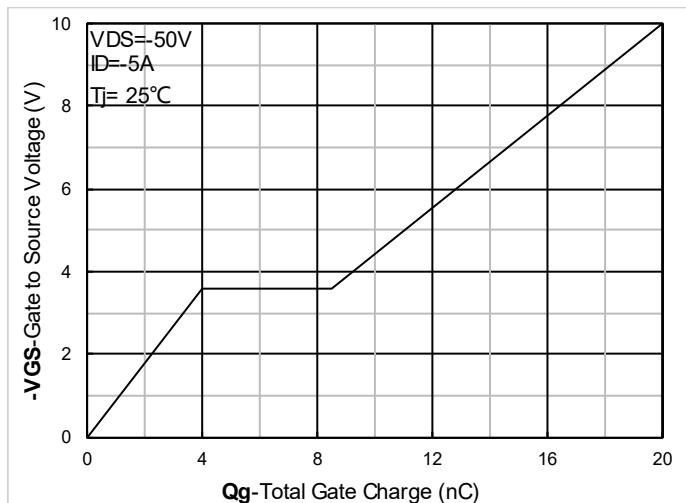


Figure 4. Gate Charge

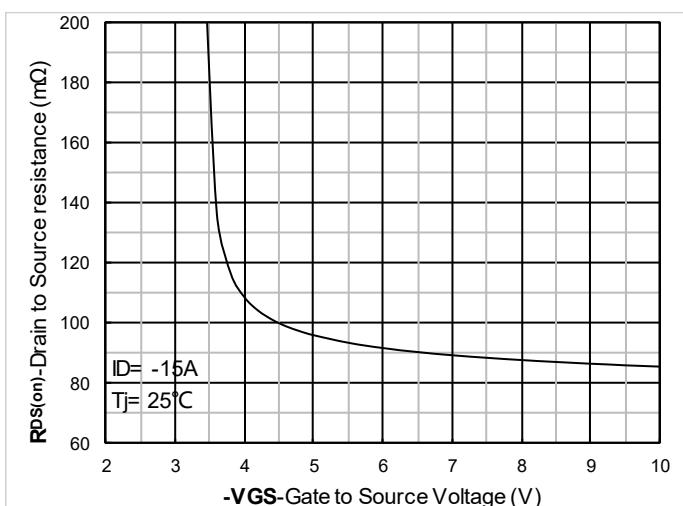


Figure 5. On-Resistance vs Gate to Source Voltage

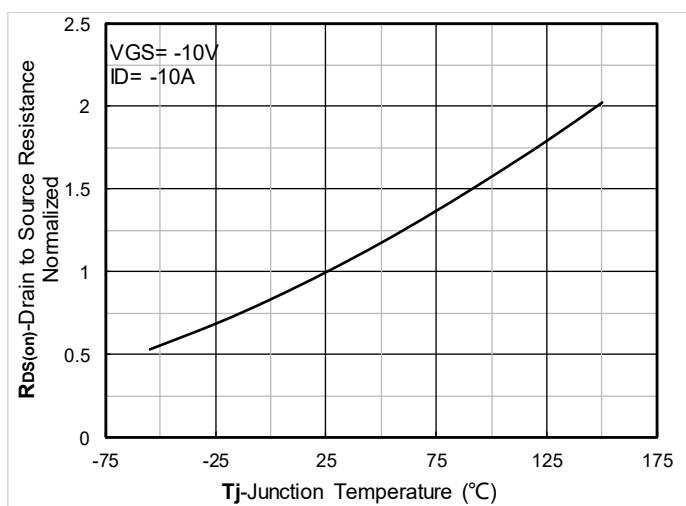


Figure 6. Normalized On-Resistance

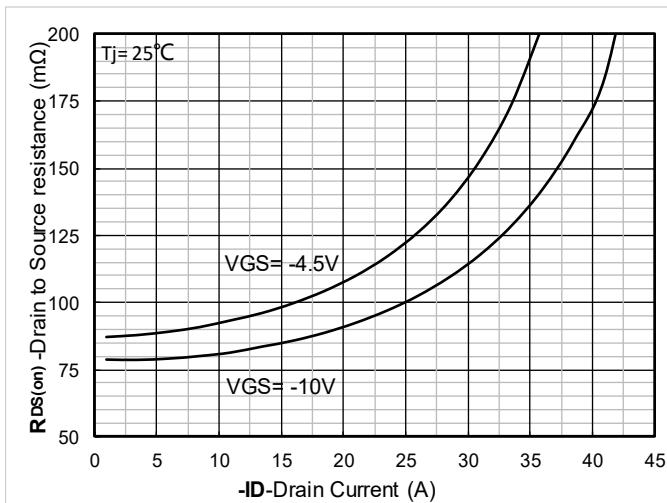
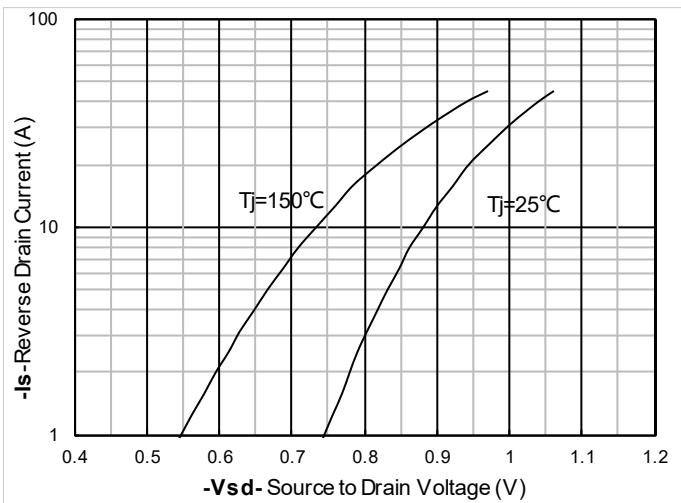
Figure 7.  $R_{DS(on)}$  VS Drain Current

Figure 8. Forward characteristics of reverse diode

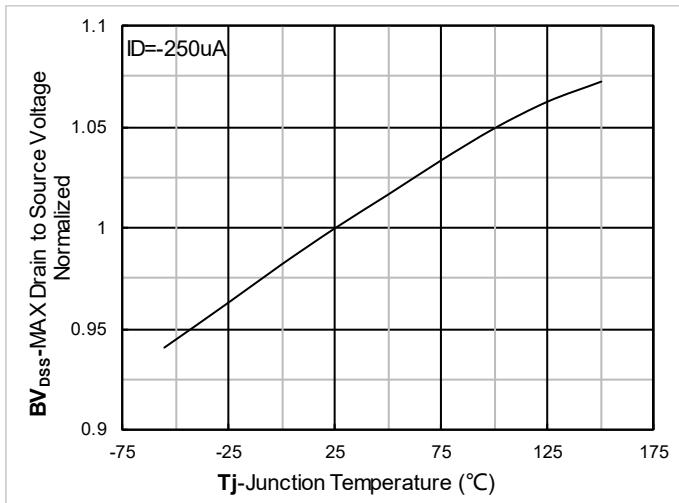


Figure 9. Normalized breakdown voltage

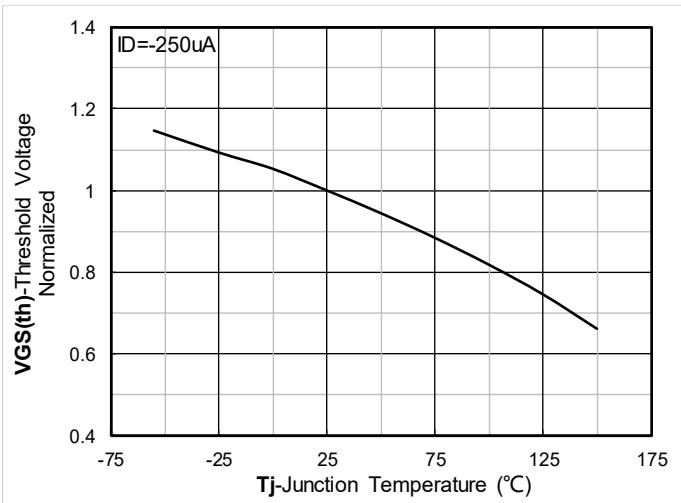


Figure 10. Normalized Threshold voltage

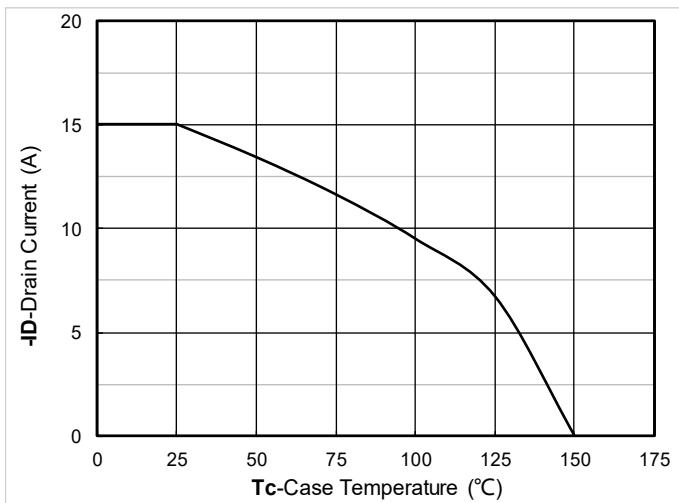


Figure 11. Current dissipation

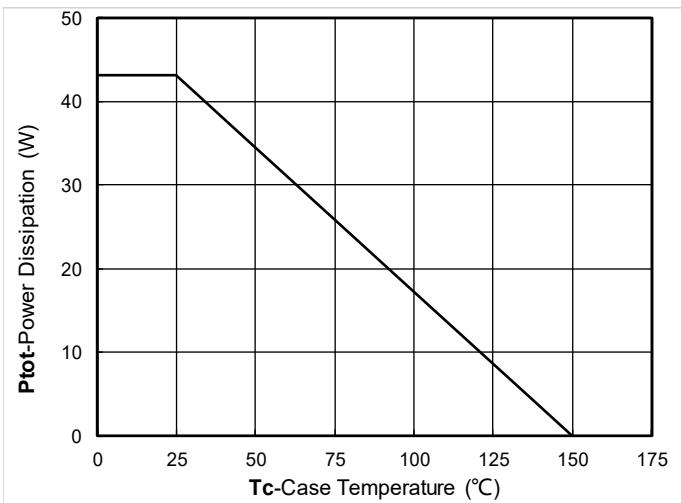


Figure 12. Power dissipation

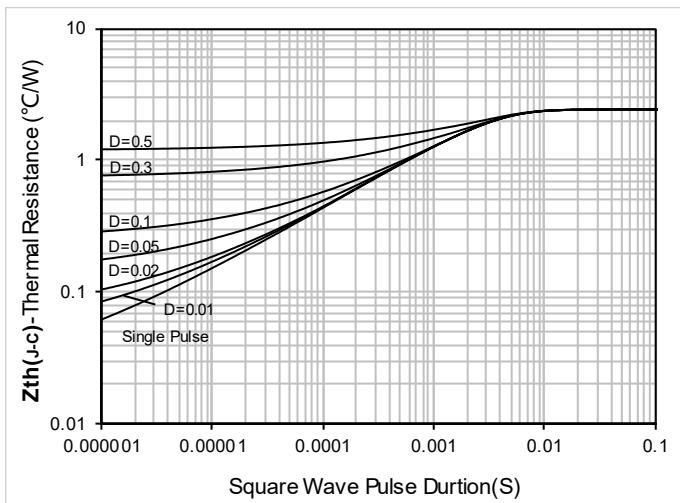


Figure 13. Maximum Transient Thermal Impedance

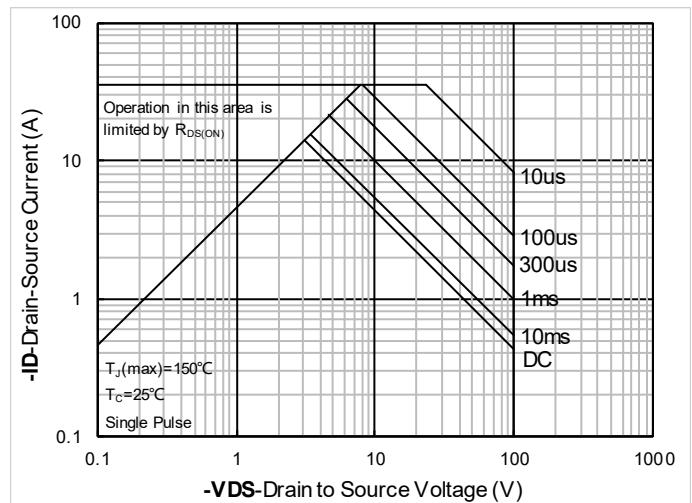
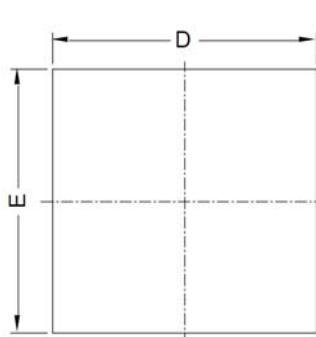
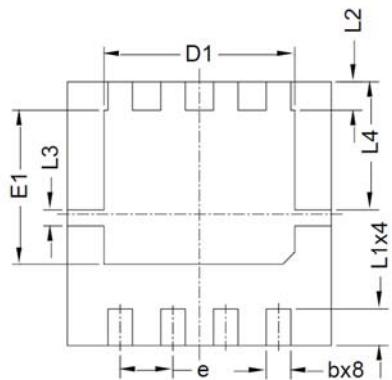
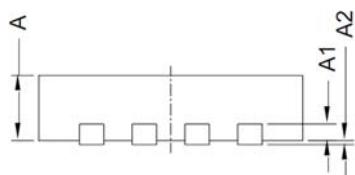
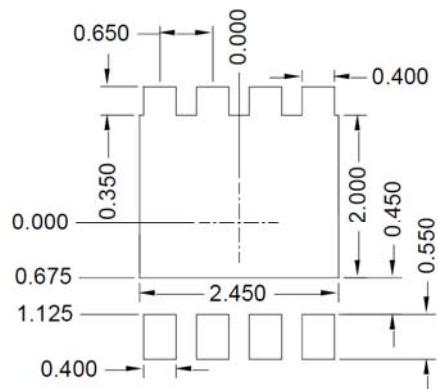


Figure 14. Safe Operation Area



## ■DFN3333-8L Package information

Top View  
正面视图Bottom View  
背面视图Side View  
侧面视图Suggested Solder Pad Layout  
Top View

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
D	3.15	3.25	3.35
E	3.15	3.25	3.35
A	0.70	0.80	0.90
A1	0.20 BSC		
A2			0.10
D1	2.20	2.35	2.50
E1	1.80	1.90	2.00
L1	0.35	0.45	0.55
L2	0.35 BSC		
L3	0.20 BSC		
L4	1.57 BSC		
b	0.20	0.30	0.40
e	0.65 BSC		

## Note:

- Controlling dimension:in millimeters.
- General tolerance: $\pm 0.10\text{mm}$ .
- The pad layout is for reference purposes only.



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